

APPLICANT'S ART CITATION <small>(Use several sheets if necessary)</small> 		Application 10/551,355		OFGS File No. P/4761-2		
		Applicant Sang-Goo LEE et al.				
		Filing Date September 28, 2005		Group Art Unit 1755		
		U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)				
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
/RK/	US-6,491,889					
	US-					
	US-					
	US-					
	US-					
FOREIGN PATENT DOCUMENTS						
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation
						Yes
/RK/	10-0384442	05-2003	Japan (equivalent U.S. Patent No. 6,468,498)			X
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
/RK/	N. Setter, et al., Flux Growth of Lead Scandium Tantalate Pb(Sc _{0.5} Ta _{0.5})O ₃ and Lead Magnesium Niobate Pb(Mg _{1/3} Nb _{2/3})O ₃ Single Crystals, Journal of Crystal Growth 50 (1980) 555-556.					
/RK/	Shoichiro Nomura et al., Recent Applications of PMN-Based Electrostrictors, Ferroelectrics, (1983), Vol. 50, pp. 197-202					
/RK/	W.A. Bonner et al., Growth of Single Crystals of P ₃ MgNb ₂ O ₉ By the Kyropoulos Technique, Mat. Res. Bull. Vol. 2, pp. 131-134, 1967.					
/RK/	Sang-Good Lee, et al., Growth and electrostrive properties of Pb(Mg _{1/3} Nb _{2/3})O ₃ Crystals, Applied Physics Letters, Vol. 74, Number 7, pp. 1030-1032.					
/RK/	Wei-Gen Luo, et al., High-Field Properties of PMN-PT Single Crystals, 1999 IEEE Ultrasonics Symposium, pp. 1009-1012.					
Examiner	/Robert Kunemund/		Date Considered	10/01/2007		
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.						

APPLICANT'S ART CITATION (Use several sheets if necessary)		Application		ORGS File No. P/47602/551355		
		Applicant Sang-Goo LEE et al.				
		Filing Date		Group Art Unit		
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)						
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
/RK/	US-2002/0193237	12-2002	Messing et al.	501	136	
/RK/	US-6,468,498	10-2002	Lee et al	423	619	
/RK/	US-6,329,656	12-2001	Whatmore	250	338.2	
/RK/	US-6,491,899	12-2002	Leinen et al.	424	49	
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	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation
						Yes
/RK/	JP01-298060 A	12-1989	Japan			abstract
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
/RK/		International Search Report PCT/KR2003/001528 dated 13 April 2004				
Examiner	/Robert Kunemund/	Date Considered	10/01/2007			

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